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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.	
10/809,070 03/25/2004		Wilfried Von Ammon	WSAG 0143 PUS	6998	
22045	7590 06/01/2006		EXAMINER		
BROOKS KUSHMAN P.C.			STARK, JARRETT J		
1000 TOWN CENTER TWENTY-SECOND FLOOR			ART UNIT	PAPER NUMBER	
SOUTHFIELD, MI 48075			2823		
			DATE MAIL ED: 06/01/2006		

Please find below and/or attached an Office communication concerning this application or proceeding.

٦.								
		Арр	lication No.	Applicant(s)				
		10/8	309,070	AMMON ET AL.				
	Office Action Summary	Exa	niner	Art Unit				
			ett J. Stark	2823				
	The MAILING DATE of this communication appears on the cover sheet with the correspondence address Period for Reply							
WHIC - Exte after - If NC - Failu Any	ORTENED STATUTORY PERIOD F CHEVER IS LONGER, FROM THE N nsions of time may be available under the provisions SIX (6) MONTHS from the mailing date of this com or period for reply is specified above, the maximum s re to reply within the set or extended period for reply reply received by the Office later than three months ed patent term adjustment. See 37 CFR 1.704(b).	MAILING DATE C s of 37 CFR 1.136(a). In munication. tatutory period will apply y will, by statute, cause I	OF THIS COMMUNICATION IN THE PROPERTY OF THIS COMMUNICATION IN THE PROPERTY OF	N. nely filed the mailing date of this communication. D (35 U.S.C. § 133).				
Status								
1)⊠	Responsive to communication(s) file	ed on <u>11 May 20</u>	<u>06</u> .					
2a)	This action is FINAL . 2b)⊠ This action is non-final.							
3)	Since this application is in condition for allowance except for formal matters, prosecution as to the merits is							
	closed in accordance with the pract	ice under <i>Ex par</i>	te Quayle, 1935 C.D. 11, 45	53 O.G. 213.				
Disposit	ion of Claims							
4) 又	Claim(s) 33-56 is/are pending in the	application.						
,—	4a) Of the above claim(s) <u>33-51 and 56</u> is/are withdrawn from consideration.							
5)	5) Claim(s) is/are allowed.							
6)⊠	Claim(s) <u>52-55</u> is/are rejected.		•					
7)	Claim(s) is/are objected to.			•				
8)	Claim(s) are subject to restri	ction and/or elec	tion requirement.					
Applicat	ion Papers		'					
9)[]	The specification is objected to by the	ne Examiner.						
	The drawing(s) filed on <u>25 March 20</u>		accepted or b) objected to	o by the Examiner.				
,	Applicant may not request that any obje			•				
Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).								
11) The oath or declaration is objected to by the Examiner. Note the attached Office Action or form PTO-152.								
Priority (under 35 U.S.C. § 119							
12) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f). a) All b) Some * c) None of:								
	1. Certified copies of the priority documents have been received.							
	2. Certified copies of the priority documents have been received in Application No							
	3. Copies of the certified copies of the priority documents have been received in this National Stage							
application from the International Bureau (PCT Rule 17.2(a)).								
* (See the attached detailed Office action	on for a list of the	ecertified copies not receive	;d .				
A44.c.b	14(2)		•		•			
Attachmer	ore of References Cited (PTO-892)		4) Interview Summary	(PTO-413)				
2) Notice	ce of Draftsperson's Patent Drawing Review (Paper No(s)/Mail D	ate				
3) Information Disclosure Statement(s) (PTO-1449 or PTO/SB/08) Paper No(s)/Mail Date 12/8/2005. 5) Notice of Informal Patent Application (PTO-152) 6) Other:								

DETAILED ACTION

Election/Restrictions

Applicant's election with traverse of Group II: (new) claims 52-55 (corresponding to previous claims 20-31) in the reply filed on 5/11/2006 is acknowledged. The traversal is on the ground(s) that "it is not believed possible" (not a complete response).

This is not found persuasive because the first standard apparatuses used for performing the Czochralski method used stationary crucibles due to the difficulty of heating (temperature control) and rotating crucibles, full of a crystal melt, at the same time. At the time it was much easier to only rotate the seed crystal.

Because applicant did not distinctly and specifically point out the supposed errors in the restriction requirement, the election has been treated as an election without traverse (MPEP § 818.03(a)).

The requirement is still deemed proper and is therefore made FINAL.

Drawings

The drawings are objected to under 37 CFR 1.83(a). The drawings must show every feature of the invention specified in the claims. Therefore, the thickness of the oxide covering a defect and the average diameter of a defect must be shown or the feature(s) canceled from the claim(s). No new matter should be entered.

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Corrected drawing sheets in compliance with 37 CFR 1.121(d) are required in reply to the Office action to avoid abandonment of the application. Any amended replacement drawing sheet should include all of the figures appearing on the immediate prior version of the sheet, even if only one figure is being amended. The figure or figure number of an amended drawing should not be labeled as "amended." If a drawing figure is to be canceled, the appropriate figure must be removed from the replacement sheet, and where necessary, the remaining figures must be renumbered and appropriate changes made to the brief description of the several views of the drawings for consistency. Additional replacement sheets may be necessary to show the renumbering of the remaining figures. Each drawing sheet submitted after the filing date of an application must be labeled in the top margin as either "Replacement Sheet" or "New Sheet" pursuant to 37 CFR 1.121(d). If the changes are not accepted by the examiner, the applicant will be notified and informed of any required corrective action in the next Office action. The objection to the drawings will not be held in abeyance.

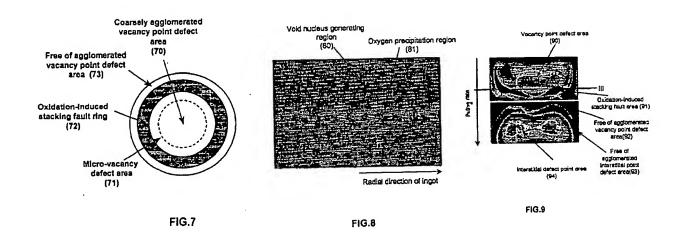
Claim Rejections - 35 USC § 103

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

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Claims 52-55 are rejected under 35 U.S.C. 103(a) as being unpatentable over Lee et al. (US 2002/0048670).



Regarding claim 52, Lee discloses a silicon semiconductor wafer with agglomerated vacancy defects (COPs) as a defect type, these defects being covered with an oxide layer whose thickness is less than 1 nm. (Lee Figs. 7-9 shown above)

In regards to the thickness of the oxide layer, as the claim reads the claim is <u>very</u> broad and can be interoperated to be the native oxide layer that covers all Si wafers (and obviously defects) once they are exposed to air. The native oxide layer is notoriously well know to be approximately 5-15 Angstroms thick.

It would have been obvious to one of ordinary skill in the art of making semiconductor devices to determine the workable or optimal value for the thickness through routine experimentation and optimization to obtain optimal or desired device performance because the thickness is a result-effective variable and there is no evidence indicating that it is critical or produces any unexpected results and it has been

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held that it is not inventive to discover the optimum or workable ranges of a resulteffective variable within given prior art conditions by routine experimentation. See
MPEP 2144.05

Lee discloses the claimed invention except for the thickness. It would have been obvious to one having ordinary skill in the art at the time the invention was made to cover the defects with a 1nm thick oxide, since it has been held that where the general conditions of a claim are disclosed in the prior art, discovering the optimum or workable ranges involves only routine skill in the art. *In re Aller*, 105 USPQ 233.

In addition, the selection of thickness, its obvious because it is a matter of determining optimum process conditions by routine experimentation with a limited number of species of result effective variables. These claims are prima facie obvious without showing that the claimed ranges achieve unexpected results relative to the prior art range. In re Woodruff, 16 USPQ2d 1935, 1937 (Fed. Cir. 1990). See also In re Huang, 40 USPQ2d 1685, 1688 (Fed. Cir. 1996)(claimed ranges or a result effective variable, which do not overlap the prior art ranges, are unpatentable unless they produce a new and unexpected result which is different in kind and not merely in degree from the results of the prior art). See also In re Boesch, 205 USPQ 215 (CCPA) (discovery of optimum value of result effective variable in known process is ordinarily within skill or art) and In re Aller, 105 USPQ 233 (CCPA 1995) (selection of optimum ranges within prior art general conditions is obvious).

Note that the specification contains no disclosure of either the critical nature of the claimed dimensions or any unexpected results arising therefrom. Where

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patentability is said to be based upon particular chosen dimensions or upon another variable recited in a claim, the Applicant must show that the chosen [dimensions] are critical. *In re Woodruf*, 919 F.2d 1575, 1578, 16 USPQ2d 1934, 1936 (Fed. Cir. 1990).

Any differences in the claimed invention and the prior art may be expected to result in some differences in properties. The issue is whether the properties differ to such an extent that the difference is really unexpected. In re Merck & Co., 800 F.2d 1091, 231 USPQ 375 (Fed. Cir. 1986).

Appellants have the burden of explaining the data in any declaration they proffer as evidence of non-obviousness. Ex parte Ishizaka, 24 USPQ2d 1621, 1624 (Bd. Pat. App. & Inter. 1992).

An Affidavit or declaration under 37 CFR 1.132 must compare the claimed subject matter with the closest prior art to be effective to rebut a prima facie case of obviousness. In re Burckel, 592 F.2d 1175, 201 USPQ 67 (CCPA 1979).

Regarding claim 53, Lee discloses the semiconductor wafer of claim 52, wherein said defects have an average diameter of less than 50 pm.

It would have been obvious to one of ordinary skill in the art of making semiconductor devices to determine the workable or optimal value for the diameter through routine experimentation and optimization to obtain optimal or desired device performance because the diameter is a result-effective variable and there is no evidence indicating that it is critical or produces any unexpected results and it has been held that it is not inventive to discover the optimum or workable ranges of a result-

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effective variable within given prior art conditions by routine experimentation. See MPEP 2144.05

Regarding claim 54, Lee discloses the silicon semiconductor wafer of claim 52, having at least one region with agglomerated interstitial atoms (LPITs) as the defect type, wherein said agglomerated interstitial atoms are so small that no secondary dislocations are also present. (Lee Figs. 7-9 shown above)

Regarding claim 55, Lee discloses the silicon semiconductor wafer of claim 53 having at least one region with agglomerated interstitial atoms (LPITs) as the defect type, wherein said agglomerated interstitial atoms are so small that no secondary dislocations are also present. (Lee Figs. 7-9 shown above)

Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Jarrett J. Stark whose telephone number is (571) 272-6005. The examiner can normally be reached on Monday - Thursday 7:00AM - 5:30PM.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Matthew Smith can be reached on (571) 272-1907. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

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Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free). If you would like assistance from a USPTO Customer Service Representative or access to the automated information system, call 800-786-9199 (IN USA OR CANADA) or 571-272-1000.

JJS May 25, 2006 Chelle Istiadi MICHELLE ESTRADA PRIMARY EXAMINER

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